Defect-Limited Efficiency of Pnictogen Chalcohalide Solar Cells

Cibrán López,^{1,2} Seán R. Kavanagh,³ Pol Benítez,^{1,2} Edgardo Saucedo,^{2,4} Aron Walsh,^{5,6} David O. Scanlon,⁷ and Claudio Cazorla^{1,2,8}

Departament de Física, Universitat Politècnica de Catalunya, 08034 Barcelona, Spain
 ²Barcelona Research Center in Multiscale Science and Engineering,
Universitat Politècnica de Catalunya, 08019 Barcelona, Spain
 ³Harvard University Center for the Environment, Cambridge, Massachusetts 02138, United States
 ⁴Departament d'Enginyeria Electrònica, Universitat Politècnica de Catalunya, 08034 Barcelona, Spain
 ⁵Thomas Young Centre and Department of Materials,
Imperial College London, Exhibition Road, London SW7 2AZ, UK
 ⁶Department of Physics, Ewha Womans University,
 52 Ewhayeodae-gil, Seodaemun-gu, Seoul 03760, South Korea
 ⁷School of Chemistry, University of Birmingham, Birmingham B15 2TT, UK
 ⁸Institució Catalana de Recerca i Estudis Avançats (ICREA),
 Passeiq Lluís Companys 23, 08010 Barcelona, Spain

Pnictogen chalcohalides (MChX) have recently emerged as promising nontoxic and environmentally friendly photovoltaic absorbers, combining strong light absorption coefficients with favorable low-temperature synthesis conditions. Despite these advantages and reported optimized morphologies, device efficiencies remain below 10%, far from their ideal radiative limit. To uncover the origin of these performance losses, we present a systematic and fully consistent first-principles investigation of the defect chemistry across the Bi-based chalcohalide family. Our results reveal a complex defect landscape dominated by chalcogen vacancies of low formation energy, which act as deep nonradiative recombination centers. Despite their moderate charge-carrier capture coefficients, the high equilibrium concentrations of these defects reduce the theoretical maximum efficiencies by 6% in BiSeI and by 10% in BiSeBr. In contrast, sulfur vacancies in BiSI and BiSBr are comparatively benign, presenting smaller capture coefficients due to weaker electron-phonon coupling. Interestingly, despite its huge nonradiative charge-carrier recombination rate, BiSeI presents the best conversion efficiency among all four compounds owing to its most suitable bandgap for outdoor photovoltaic applications. Our findings identify defect chemistry as a critical bottleneck in MChX solar cells and proposes chalcogen-rich synthesis conditions and targeted anion substitutions as effective strategies for mitigation of detrimental vacancies.

Keywords: first-principles calculations, emergent photovoltaics, pnictogen chalcohalides, defect chemistry, electron-phonon coupling

I. INTRODUCTION

The global transition toward sustainable and low-carbon energy systems has placed photovoltaics (PV) at the forefront of research and technological innovation. As a clean, renewable, and abundant energy source, PV provides a direct route to decarbonizing electricity generation. However, photovoltaic technologies must satisfy stringent performance criteria, including high power conversion efficiency (PCE), long-term stability, scalability, and low-cost manufacturing, while maintaining environmental sustainability. ²

Pnictogen chalcohalides (MChX, Fig. 1a) have recently emerged as a promising class of photovoltaic absorbers owing to their nontoxicity, bandgaps in the range of 1.2–2.1 eV, light absorption coefficients spanning from 25 to 66 μ m⁻¹,^{3–5} exceptional thermodynamic stability,^{6,7} and low synthesis temperatures (below 300°C).^{7,8} MChX materials are often described as "perovskite-inspired" semiconductors,⁹ since their electronic structures resemble those of lead-halide perovskites, despite crystallizing in different crystal lattices. In particular, such materials are believed to present defect tolerance, stemming from

antibonding and bonding character of their valence and conduction bands, respectively. Actually, the closely related family of binary chalcogenides (e.g., $\mathrm{Sb_2S_3}$, $\mathrm{Sb_2Se_3}$, and $\mathrm{Bi_2S_3}$) has been shown to exhibit genuine defect-tolerance features. $^{10-12}$

Despite these encouraging prospects, experimental PCEs of MChX solar cells remain below 10%, far from their ideal Shockley-Queisser limit obtained from detailed balance (e.g., 30% in BiSeI). 13,14 Understanding the origin of this performance decline is therefore essential for realizing their full technological potential and enabling large-scale deployment. While efficiency losses can arise from synthesis routes, morphology, or even device architecture, recent studies indicate that such extrinsic factors are not the primary bottlenecks in MChX absorbers.^{5,9} Instead, intrinsic defects are increasingly recognized as the decisive factor. Extended, high-dimensional defects such as grain boundaries, dislocations, and precipitates, although typically detrimental in many semiconductors, are found to be noncritical in MChX⁸ since their quasi-one-dimensional chain-like framework appears to hinder charge recombination. 15-17 On the other hand, point defects, often overlooked in

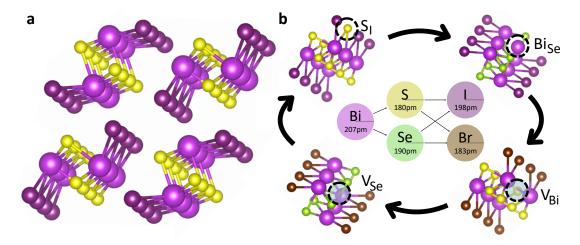


FIG. 1. MChX photovoltaic absorbers. a. MChX orthorhombic crystal structure (space group *Pnma*) characterized by columnar motifs held together by weak dispersion forces. Pnictogen, chalcogen and halide atoms are represented by violet, yellow and dark pink spheres, respectively. b. A systematic study of MChX point defects disentangles general trends. Four different Bi-based chalcohalides and all possible intrinsic point defects have been systematically analyzed in this study. The van der Waals radius of each species is marked for reference.

early assessments, may dominate nonradiative recombination and ultimately constrain device performance. ^{18,19}

Recent theoretical studies on $BiSeI^{19}$ and their binary counterparts $Sb_2S_3^{20}$ and $Sb_2Se_3^{21}$ have identified chalcogen vacancies as dominant recombination centers, drastically reducing their maximum PCE. Experimental works have also reported similar defect behaviour in related materials. Consequently, sulfur and selenium vacancies (V_S and V_{Se}) might play a significant detrimental role in the broader MChX family. Yet, their relative impact on device performance may differ substantially depending on the interplay of the local chalcogen—halogen environment, which motivates a systematic, cross-material computational investigation of point defects on pnictogen chalcohalides.

Systematically estimating point-defect behaviour (e.g., formation energies and carrier capture coefficients) in MChX is highly nontrivial. First-principles calculations of defect formation energies and carrier capture processes are computationally demanding and highly sensitive to methodological choices. Comparisons across different studies are often complicated variations in input parameters or approximations, often relying on error cancellation, which hinders finding any general trends. By contrast, a consistent, family-wide study performed with identical computational protocols offers a robust framework to disentangle chemical effects from methodological artifacts (Fig. 1b). 19,31

Here, we present a comprehensive investigation of the defect chemistry of four representative pnictogen chalco-halides (BiSI, BiSeI, BiSBr, and BiSeBr) using advanced first-principles density functional theory (DFT) calculations. A systematic comparison of all of them allows identifying selenium vacancies as the most detrimental defects within this family; in particular, they introduce deep electronic transition states near the Fermi level and

enhance electron—phonon coupling, thus promoting non-radiative recombination in BiSeI and BiSeBr. In contrast, sulfur vacancies in BiSI and BiSeBr are comparatively benign, owing to weaker electron-phonon coupling, despite presenting similar formation energies. This striking contrast originates from the larger ionic radius and higher polarizability of selenium atoms, which enhance lattice distortions around $V_{\rm Se}$, suggesting that the chemical environment (specifically, the interplay between chalcogen and halogen anions) dictates charge recombination activity in MChX. This work establishes design principles for defect engineering in pnictogen chalcohalides, while also offering a generalizable framework applicable to other emergent photovoltaic materials.

II. RESULTS

MChX crystallize into an orthorhombic phase (space group *Pnma*) characterized by one-dimensional columns held together by weak van der Waals forces (Fig. 1a), oldsely resembling the structure of binary pnictogen chalcogenides (Sb₂S₃, Sb₂Se₃ and Bi₂Se₃¹⁵). Our DFT geometry optimizations for MChX yield lattice parameters that are in very good agreement with the available experimental data^{3,9} (Supplementary Table I). According to previous first-principles calculations and experimental observations, observations, the mental observations are thermodynamically stable against phase separation into secondary phases (Supplementary Fig. 1) and present indirect bandgaps in the range of 1 to 2 eV (Supplementary Fig. 2).

Material		Bi-poor	•		S/Se-poor	•
	μ_{Bi}	$\mu_{\mathrm{S/Se}}$	$\mu_{\mathrm{I/Br}}$	μ_{Bi}	$\mu_{ m S/Se}$	$\mu_{\mathrm{I/Br}}$
BiSI	-0.87	Ó	-0.46	0	-0.58	-0.75
BiSeI	-0.97	0	-0.42	0	-0.65	-0.75
BiSBr	-0.90	0	-0.67	0	-0.60	-0.97
${ m BiSeBr}$	-1.03	0	-0.63	0	-0.68	-0.97

TABLE I. Calculated chemical potential limits for the thermodynamic stability window of MChX compounds. Bi-poor and S/Se-poor conditions are the two limiting cases. Chemical potentials are expressed in units of eV.

A. Defect Formation Energies

Point defects play a pivotal role in the optoelectronic performance of semiconductors. They can compensate for doping-induced electrical imbalance, shift the Fermi energy level $(E_{\rm F})$, and act as deep nonradiative charge recombination centers that quench carrier lifetimes and limit photovoltaic performance. To assess their impact on MChX, we computed the formation energies $(E_{\rm f})$ of all relevant point defects as a function of the Fermi energy level (delimited by the valence band maximum and conduction band minimum, VBM $\leq E_F \leq$ CBM) for BiSI, BiSeI, BiSBr and BiSeBr. In practice, low (high) defect formation energies imply high (low) equilibrium concentration of defects, as follows from the corresponding Boltzmann-like distribution.

Defect formation energy diagrams (Supplementary Figs. 3–11) provide a compact map of thermodynamic stability: the slope of each line reflects the defect charge state, the intersections mark charge-state transition levels (acceptance or donation of electrons), and the relative position of the curves identifies which defects are most favorable under given synthesis conditions. In terms of PV performance, the most detrimental defects are those with low formation energies near the self-consistent Fermi level, $E_F^{\rm sc}$. 32,33 This equilibrium Fermi level ensures charge neutrality across the defect and carrier populations in the system, 34 and it can be shifted with temperature and growth conditions.

The influence of chemical environment on $E_{\rm f}$ enters explicitly through the atomic chemical potentials (Methods), which bound the accessible growth window during synthesis. For MChX, the two pnictogen-poor and chalcogen-poor limits are particularly relevant (Table I). These limits capture the experimentally relevant conditions where defect chemistry is expected to differ most strongly, while intermediate states interpolate between them. During experimental synthesis, chalcogen-poor conditions are frequently encountered owing to the high volatility of Se and S atoms at elevated temperatures.^{7,8}

In the following sections, we focus on vacancies and antisites since these point defects consistently emerge as the lowest-energy across MChX. In fact, interstitials exihibit significantly higher formation energies¹⁹ (Supplementary Fig. 3), in agreement with experimental observations in binary chalcogenides,^{35–38} and are therefore

excluded from our next detailed analysis.

1. BiSI

At room temperature, $E_F^{\rm sc}$ lies 1.57 eV above the VBM in Bi-poor environments and 1.70 eV in S-poor environments, considering defect populations set at a realistic annealing temperature of 550 K (Supplementary Fig. 4). The calculated $E_F^{\rm sc}$ exhibits a weak dependence on temperature (Supplementary Fig. 5), which denotes robust n-type character.

BiSI exhibits a high density of deep midgap charge-transition states that are likely to act as recombination centers (Fig. 2a). These mostly include antisites, with Bi_S showing three transitions (+5/+3, +3/+1, +1/-1) at 1.06–1.23 eV from the VBM, complemented by Bi_I (+5/0) and S_{Bi} (+1/-1) at 1.14 and 1.07 eV, respectively. Sulfur vacancies with charge-transition state (+2/0) represent deep levels, positioned at 1.23 eV from the VBM.

Under S-poor conditions, V_S exhibits a formation energy of 0.77 eV at the self-consistent Fermi level, $E_F^{\rm sc}$ (Supplementary Fig. 5). Several antisite defects present also very low formation energies at $E_F^{\rm sc}$, the most critical cases being S_I (0.51 eV) and $B_{\rm iS}$ (0.54 eV). Bi-poor synthesis conditions generally result in higher formation energies. For example, the formation energy of V_S increases to 1.34 eV. However, certain antisite defects still exhibit very low E_f : 0.35 eV for S_I and 0.80 eV for $S_{\rm Bi}$.

These results have a direct effect on the equilibrium defect populations, which are highest under S-poor conditions with, for example, $4.7\times10^{16}~{\rm cm^{-3}}$ for $I_{\rm S},~3.0\times10^{15}~{\rm cm^{-3}}$ for $S_{\rm I},~2.1\times10^{15}~{\rm cm^{-3}}$ for $V_{\rm S}$ and $1.6\times10^{15}~{\rm cm^{-3}}$ for $Bi_{\rm S}$ (Fig. 2b). On the contrary, these populations are moderate under Bi-poor conditions with, for example, $1.2\times10^{16}~{\rm cm^{-3}}$ for $I_{\rm S}$ and $S_{\rm I}.$

2. BiSeI

In BiSeI, the defect landscape is similar to that of BiSI but with slightly different energetics (Supplementary Fig. 6). $V_{\rm Se}$ forms at 0.82 eV under Se-poor and 1.47 eV under Bi-poor conditions. Bi_{Se} is highly favorable, requiring only 0.34 eV under Se-poor growth but increasing to 2.04 eV in Bi-poor environments. The equilibrium Fermi level is again pinned high in the gap, 1.38 eV above the VBM under Bi-poor and 1.46 eV under Se-poor conditions, with little dependence on annealing temperature (Supplementary Fig. 7).

Similarly to BiSI, BiSeI exhibits deep levels such as $\rm Bi_{Se}~(+5/+1)$ positioned at 1.10 eV, $\rm Bi_{I}~(+4/0)$ at 1.12 eV from the VBM, $\rm Se_{I}~(+1/-1)$ at 0.87 eV, $\rm Se_{Bi}~(+1/-1)$ at 1.06 eV, and $\rm V_{Se}~(+2/0)$ at 1.08 eV (Fig. 3a). While in BiSeI there are fewer deep charge-transition states than in BiSI, the parallels between the two iodides indicate a shared tendency for potentially recombination-active centers.

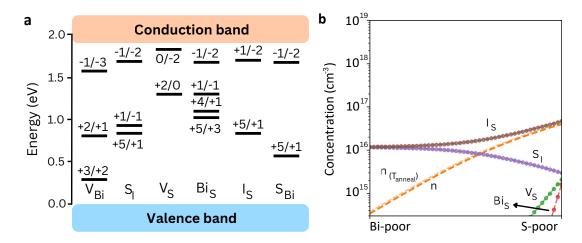


FIG. 2. **Point-defect chemistry in BiSI. a.** Charge-state transition levels of the most prominent (i.e., lowest energy) point defects determined for BiSI. **b.** Defect concentrations of BiSI considering an annealing temperature of 550 K. The chemical stability region is delimited by S-poor (μ_{Bi} , μ_{S} , μ_{I}) = (0, -0.58, -0.75) eV and Bi-poor conditions (μ_{Bi} , μ_{S} , μ_{I}) = (-0.87, 0, -0.46) eV.

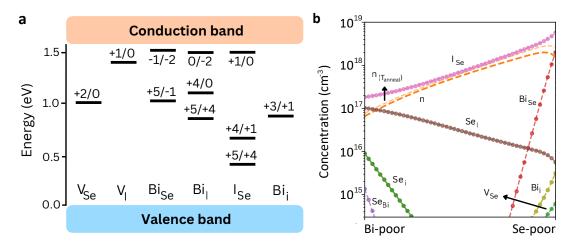


FIG. 3. **Point-defect chemistry in BiSeI. a.** Charge-state transition levels of the most prominent (i.e., lowest energy) point defects determined for BiSeI. **b.** Defect concentrations of BiSeI considering an annealing temperature of 550 K. The chemical stability region is delimited by Se-poor (μ_{Bi} , μ_{Se} , μ_{I}) = (0, -0.65, -0.75) eV and Bi-poor conditions (μ_{Bi} , μ_{Se} , μ_{I}) = (-0.97, 0, -0.42) eV.

The most critical antisites (Supplementary Fig. 6) are $\rm Bi_{Se}$ (0.34 eV) and $\rm I_{Se}$ (0.43 eV) under Se-poor conditions, while under Bi-poor conditions are $\rm I_{Se}$ (0.68 eV) and $\rm Se_{I}$ (0.38 eV). As in BiSI, the formation energy of vacancies are slightly higher than those of antisites. However, $\rm V_{Se}$ emerges as a key recombination-active defect with $E_{\rm f}=0.82$ eV, this formation energy being slightly lower than that of $\rm V_{S}$ in BiSI.

Once again, we found that the equilibrium defect populations are highest under Se-poor conditions, with 5.8×10^{18} cm⁻³ for $I_{\rm Se}$, 5.6×10^{15} cm⁻³ for Se_I, 6.1×10^{14} cm⁻³ for $V_{\rm Se}$ and 2.0×10^{18} cm⁻³ for $Bi_{\rm Se}$ (Fig. 3b). Meanwhile, under Bi-poor conditions, we obtain 1.8×10^{17} cm⁻³ for $I_{\rm Se}$ and 1.0×10^{17} cm⁻³ for Se_I. These equilibrium defect concentrations in general are higher than found in BiSI. Consequently, it can be inferred that in BiSeI trap-mediated

recombination would probably be more pronounced.

3. BiSBr

BiSBr (Supplementary Fig. 8) shows the strongest n-type tendency since $E_F^{\rm sc}$ is pinned at 1.82 eV above the VBM under Bi-poor and shifts further to 1.98 eV in S-poor conditions (Supplementary Fig. 9). Deep levels arise from both cationic and anionic sites (Fig. 4a): Bi_S (+3/-1) at 1.34 eV from the VBM, Bi_{Br} (+4/+2, +2/0) at 1.25 and 1.47 eV, respectively, $S_{\rm Bi}$ (+1/-1) at 1.35 eV, $V_{\rm S}$ (+2/0) at 1.50 eV, and $V_{\rm Bi}$ (+1/-1) at 1.38 eV. These states reduce the dominance of antisite deep transitions while introducing an additional recombination pathway through the Bi vacancy.

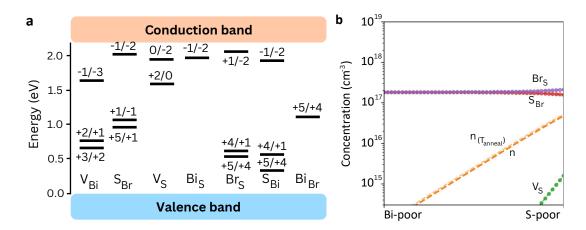


FIG. 4. **Point-defect chemistry in BiSBr. a.** Charge-state transition levels of the most prominent (i.e., lowest energy) point defects determined for BiSBr. **b.** Defect concentrations of BiSBr considering an annealing temperature of 550 K. The chemical stability region is delimited by S-poor (μ_{Bi} , μ_{S} , μ_{Br}) = (0, -0.60, -0.97) eV and Bi-poor conditions (μ_{Bi} , μ_{S} , μ_{Br}) = (-0.90, 0, -0.67) eV.

In BiSBr, the lowest-energy antisites are $S_{\rm Br}$ and $Br_{\rm S}$, with $E_{\rm f}=0.34~{\rm eV}$ and 0.72 eV under S-poor growth, respectively. Under Bi-poor conditions, $S_{\rm Br}$ becomes particularly easy to form, with $E_{\rm f}$ dropping to 0.20 eV, while $S_{\rm Bi}$ also remains competitive (0.73 eV). Although vacancies formation is energetically less favorable, $V_{\rm S}$ again emerges as the lowest-energy case, with $E_{\rm f}=0.79~{\rm eV}$ under S-poor, closely resembling previous cases. This hierarchy reflects the structural penalty for removing atoms from the quasi-1D columns, in contrast to antisites, which require minimal rearrangement.

The equilibrium defect populations were found to closely resemble those in BiSI, with $2.1\times10^{17}~{\rm cm^{-3}}$ for ${\rm Br_S},\,1.6\times10^{17}~{\rm cm^{-3}}$ for ${\rm S_{Br}},\,{\rm and}\,1.6\times10^{15}~{\rm cm^{-3}}$ for ${\rm V_S}$ in S-poor conditions, and $1.8\times10^{17}~{\rm cm^{-3}}$ for ${\rm Br_S}$ and ${\rm S_{Br}}$ in Bi-poor conditions (Fig. 4b). As a result, it would be expected for BiSBr to have similar trap-mediated efficiency losses to BiSI.

4. BiSeBr

BiSeBr displays the richest set of midgap transitions (Fig. 5a), including $\rm Bi_{Se}~(+5/-1)$ at 0.94 eV from the VBM, $\rm Bi_{Br}~(+4/+2,~+2/0)$ at 0.76 and 1.14 eV, respectively, $\rm Br_{Bi}~(0/-2)$ at 0.82 eV, $\rm Se_{Bi}~(+1/-1)$ at 1.10 eV, $\rm V_{Se}~(+2/0)$ at 1.08 eV, and $\rm V_{Bi}~(+1/-1)$ at 0.99 eV. This diversity exceeds that of BiSBr and the iodides, marking BiSeBr as the most defect-sensitive compound in the series.

In BiSeBr, Se-related defects dominate (Supplementary Fig. 10). V_{Se} forms at 0.74 eV under Se-poor conditions and 1.42 eV under Bi-poor. Bi_{Se} is also competitive under Se-poor conditions, with $E_f = 0.56$ eV, but not so under Bi-poor growth since its formation energy then increases to 2.43 eV. The equilibrium Fermi level lies 1.33 eV above the VBM under Bi-poor conditions

and 1.49 eV in Se-poor, indicating once again a robust n-type character (Supplementary Fig. 11).

The most critical antisites in Se-poor environments are $\mathrm{Se_{Br}}$ (0.44 eV) and $\mathrm{Br_{Se}}$ (0.49 eV) (Supplementary Fig. 10). Under Bi-poor conditions, $\mathrm{Se_{Br}}$ (0.26 eV) and $\mathrm{Se_{Bi}}$ (0.59 eV) remain highly favorable. Vacancies, though less favorable than antisites, still yield relatively low formation energies, with $\mathrm{V_{Se}}$ (0.74 eV) acting as a likely nonradiative recombination center, quite close in energy to $\mathrm{V_{S}}$ in BiSI.

Again, the equilibrium defect populations are elevated under Se-poor conditions, with $2.8\times10^{18}~\rm cm^{-3}$ for $\rm Br_{Se}$, $1.5\times10^{17}~\rm cm^{-3}$ for $\rm Se_{Br}$, $1.3\times10^{16}~\rm cm^{-3}$ for $\rm Se_{Br}$ and $4.0\times10^{15}~\rm cm^{-3}$ for $\rm V_{Se}$ (Fig. 5b). Under Bi-poor conditions, however, these equilibrium concentrations noticeably decrease: $6.2\times10^{17}~\rm cm^{-3}$ for $\rm Br_{Se}$ and $\rm Se_{Br}$, $1.9\times10^{15}~\rm cm^{-3}$ for $\rm Se_{Bi}$ and $5.2\times10^{14}~\rm cm^{-3}$ for $\rm V_{Bi}$. These equilibrium defect concentrations are similar to those found in BiSeI, and slightly higher than for BiSBr, thus it can be expected that BiSeBr, along with BiSeI, present more trap-mediated recombination than BiSI and BiSBr.

5. General trends

Clear and systematic trends emerge from the defects formation results obtained for BiSI, BiSeI, BiSBr and BiSeBr (Figs. 2–5). Our calculations show that $E_F^{\rm sc}$ depends only weakly on annealing, indicating a robust n-type character across the MChX family. This behavior aligns with experimental observations that p-type doping is extremely challenging in these materials. Under chalcogen-poor conditions, Bi_{Ch} antisites consistently rank among the lowest energy defects. This preference originates from the similar atomic environments found around Bi and chalcogen positions along the quasi-one-

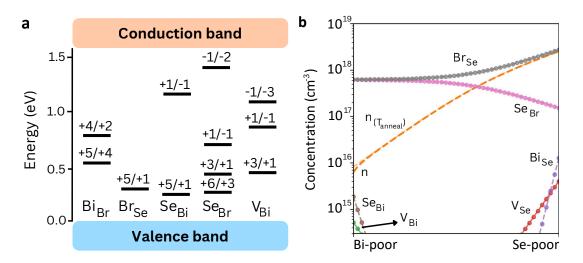


FIG. 5. **Point-defect chemistry in BiSeBr. a.** Charge-state transition levels of the most prominent (i.e., lowest energy) point defects determined for BiSeBr. **b.** Defect concentrations of BiSeBr considering an annealing temperature of 550 K. The chemical stability region is delimited by Se-poor (μ_{Bi} , μ_{Se} , μ_{Br}) = (0, -0.68, -0.97) eV and Bi-poor conditions (μ_{Bi} , μ_{Se} , μ_{Br}) = (-1.03, 0, -0.63) eV.

dimensional chains (Fig. 1a). Likewise, chalcogen-on-halogen substitutions ($\mathrm{Ch_X}$) repeatedly show very low formation energies, as seen for both S- and Se-based compounds, which can be rationalized by the comparable ionic radii of these species (Fig. 1b). While the formation of vacancies is in general energetically less favorable, $\mathrm{V_{Ch}}$ consistently emerges as the dominant vacancy type. In Bi-poor environment, the formation of $\mathrm{Ch_X}$ antisites remains the most favorable across all four materials, systematically followed by chalcogen-on-pnictogen ($\mathrm{Ch_M}$) and halogen-on-chalcogen ($\mathrm{X_{Ch}}$) substitutions. At the same time, $\mathrm{V_M}$ becomes the vacancy species with the lowest formation energies.

These general defects formation energy trends can be intuitively understood in terms of the quasi-one dimensional crystal structure characteristic of MChX. Point defects are largely confined to the atomic columns in which they form, minimizing interactions with neighboring chains. Vacancies, which require substantial lattice relaxation within a column, exhibit moderate formation energies, whereas interstitials are even more energetically costly due to the extensive lattice disruption they introduce. By contrast, antisite defects, involving the replacement of one atom by another within the same column, require minimal structural rearrangement and are therefore easier to form. These patterns are consistent with prior observations in columnar pnictogen chalcogenides such as $\mathrm{Sb}_2\mathrm{S}_3$ and $\mathrm{Sb}_2\mathrm{Se}_3$. 18,39

B. Charge-Carrier Capture Coefficients

Carrier capture coefficients $(C_{n/p})$ provide a quantitative measure of the strength of electron-phonon coupling during defect-mediated charge exchange. While defect formation energies determine which defects are most

abundant, carrier capture coefficients define which of those defects are electronically harmful by dictating how efficiently they can trap and recombine carriers. 40 Defects with high $C_{n/p}$ act as efficient nonradiative recombination centers, drastically reducing carrier lifetimes and photovoltaic performance. Within multiphonon emission theory, 23 these coefficients are calculated from the overlap of vibrational wavefunctions corresponding to different charge states, whose equilibrium geometries are connected through a generalized configuration coordinate, Q (Fig. 6).

For BiSI (Supplementary Figs. 12,13), the most prominent recombination-active centers are associated with sulfur-related defects (Supplementary Table II). We find particularly strong electron capture for the sulfur vacancy, with $C_n(V_S, 0/+1) = 2.94 \times 10^{-8}$ cm³/s, accompanied by a notable contribution from the antisite transition $C_n(\text{Bi}_S, -1/0) = 2.40 \times 10^{-10}$ cm³/s and $C_n(\text{Bi}_S, +4/+5) = 1.06 \times 10^{-8}$ cm³/s.

In BiSeI (Supplementary Figs. 14,15), the selenium vacancy emerges as the dominant nonradiative defect (Supplementary Table III), exhibiting multiple strong capture channels: $C_p(\rm V_{Se},0/+1)=5.89\times 10^{-8}~\rm cm^3/s,$ $C_n(\rm V_{Se},-1/0)=6.71\times 10^{-9}~\rm cm^3/s,$ and $C_n(\rm V_{Se},+1/+2)=1.24\times 10^{-9}~\rm cm^3/s.$ These values are approximately one order of magnitude higher than those observed in BiSI, indicating a more severe role of chalcogen vacancies in the selenides. Additional contributions arise from antisite defects such as Bi_{Se}, with transitions (-2/-1) and (-1/0) yielding coefficients of $5.53\times 10^{-10}~\rm cm^3/s$ and $5.88\times 10^{-10}~\rm cm^3/s$, respectively. These antisites, while less active than $\rm V_{Se}$, still underscore the vulnerability of iodide compounds to midgap recombination centers.

In BiSBr (Supplementary Figs. 16,17), the sulfur vacancy again proves decisive (Supplementary Table IV), with $C_n(V_S, -2/-1) = 4.66 \times 10^{-9} \text{ cm}^3/\text{s}$. Interest-

ingly, this material also displays significant antisite activity, with $C_n(\mathrm{Bi_S}, +1/+2) = 1.69 \times 10^{-9} \ \mathrm{cm^3/s}$ and $C_p(\mathrm{Bi_S}, +3/+4) = 5.99 \times 10^{-10} \ \mathrm{cm^3/s}$. Compared to the iodides, BiSBr distributes its recombination activity more evenly between vacancies and antisites, although presenting fewer recombination pathways.

BiSeBr (Supplementary Figs. 18,19) follows the same overall pattern as BiSeI, with selenium vacancies acting as the most harmful recombination centers (Supplementary Table V). A very interesting result is the extraordinarily high hole capture rate $C_p({\rm V_{Se}},0/+1)=2.95\times 10^{-5}~{\rm cm}^3/{\rm s}$, three orders of magnitude larger than in any other member of the series, firmly establishing V_{Se} as the dominant nonradiative defect in this compound. Additional strong recombination channels in BiSeBr include $C_n({\rm V_{Se}},-2/-1)=1.31\times 10^{-9}~{\rm cm}^3/{\rm s}$ and the antisite transition $C_p({\rm Bi_{Se}},-1/0)=8.85\times 10^{-9}~{\rm cm}^3/{\rm s}$.

The origin of the unusually large hole capture coefficient C_p in BiSeBr is the almost zero hole energy capture barrier, ΔE_p (Fig. 6a, Supplementary Table V), which strongly promotes hole trapping. In fact, the relationship between the calculated potential energy surfaces and the resulting carrier-capture coefficients can be understood through the "classical" energy capture barriers.^{23,41} These barriers are defined as the energy difference between the equilibrium geometry of the initial charge state and the crossing point of the corresponding potential energy surfaces $(q \rightarrow q + 1 \text{ for } \Delta E_p \text{ and }$ $q+1 \rightarrow q$ for ΔE_n). In this framework, small barriers lead to fast carrier capture, whereas large barriers result in reduced capture coefficients. For example, BiSBr exhibits a much higher hole energy capture barrier than Bi SeBr ($\Delta E_p = 3.58$ eV, Fig. 6b and Supplementary Table IV) resulting in a C_p that is eight orders of magnitude smaller. Nevertheless, both compounds display comparable electron energy capture barriers, ΔE_n , leading to similarly moderate electron capture coefficients.

These results reveal that chalcogen vacancies (particularly $\rm V_{Se}$) dominate the nonradiative recombination landscape in MChX, with capture coefficients orders of magnitude larger than those of antisites. These values are closely in line with results obtained for binary chalcogenides, which amount to $C_n(\rm V_S, +1/+2)=7.64\times 10^{-6}~\rm cm^3/s$ and $C_p(\rm V_S, +1/+2)=2.25\times 10^{-8}~\rm cm^3/s$ for $\rm Sb_2S_3,^{20}$ and $C_n(\rm V_{Se}, +1/+2)=5.63\times 10^{-6}~\rm cm^3/s$ and $C_p(\rm V_{Se}, +1/+2)=1.22\times 10^{-8}~\rm cm^3/s$ for $\rm Sb_2Se_3,^{21}$ For MChX, the sulfides exhibit somewhat weaker electron–phonon coupling than the selenides, explaining their lower recombination activity despite similar defect energetics. Antisites such as $\rm Bi_{Ch}$, although often abundant, generally display smaller capture coefficients and consequently can be regarded as comparatively benign.

C. Power Conversion Efficiencies

The previous analysis of defect formation energies and charge-carrier capture coefficients highlights the potential impact of intrinsic defects on nonradiative recombination in MChX absorbers. To place these effects in context, we first consider the ideal case: the detailed balance model, ¹³ which neglects nonradiative carrier losses and establishes the theoretical radiative limits for the MChX family (Table II and Fig. 7).

At room temperature, and accounting for thicknessdependent absorptivity in a 700 nm absorber layer, BiSI achieves a maximum power conversion efficiency (η) of 23.63%, with an open-circuit voltage (V_{oc}) of 1.66 Vand a fill factor (FF) of 92.08%. BiSeI, benefiting from its narrower band gap (Table II), reaches an ideal η of 30.38% with $V_{oc} = 1.33$ V and FF = 90.54%, underscoring the intrinsic suitability of the iodides as outdoor photovoltaic absorbers. Among the bromides, BiSBr exhibits the lowest predicted efficiency, with a detailed balance η of 17.65%, despite a comparatively high V_{oc} of 1.92 V and FF of 92.94%. Its poor efficiency arises directly from its wide band gap (Table II), which severely limits photocurrent generation. BiSeBr, in contrast, performs on par with BiSeI, achieving a maximum η of 27.96% (V_{oc} = 1.35 V, FF = 90.66%). Taken together, these results demonstrate that S-based compounds inherently yield lower η than Se-based compounds due to wider band gaps of the former.

Despite these favorable radiative limits, experimental η values for MChX solar cells have not surpassed thus far 10%.^{8,42,43} While extrinsic factors such as film morphology, interface quality, and device architecture undoubtedly contribute, our results indicate that defect-assisted nonradiative recombination is also a critical bottleneck. To quantify its impact, we evaluated the defect-limited maximum η using the calculated carrier capture coefficients $(C_{n/p})$, defect concentrations, and related parameters (Methods).⁴⁴

Under Ch-poor synthesis conditions and an annealing temperature of 550 K, η decreases only marginally for the sulfides, to 23.20% for BiSI and 17.26% for BiSBr, corresponding to a reduction of just 0.4% compared to the radiative limit (Table II). In contrast, for the selenides the effect is much stronger: η drops to 24.23% for BiSeI and 18.21% for BiSeBr, representing losses of 6% and 10%, respectively (Fig. 7). These reductions are accompanied by significant drops in V_{oc} , falling to 1.08 V for BiSeI and 0.91 V for BiSeBr, while remaining nearly unchanged for BiSI and BiSBr. The fill factor is uniformly reduced by about 2% across all Bi-based chalcohalides. By comparison, Bi-poor conditions have negligible influence, effectively minimizing the impact of trap-mediated recombination on photovoltaic performance (Table II).

Separate η calculations (Supplementary Table VI), in which we isolate the recombination effects of chalcogen vacancies and Bi_{Ch} antisites, reveal that the efficiency loss arises entirely from chalcogen vacancies, which act as strong nonradiative centers. Antisite defects, despite their low formation energies, exhibit extremely small carrier capture coefficients and can therefore be regarded as electronically benign. A similar picture holds across the

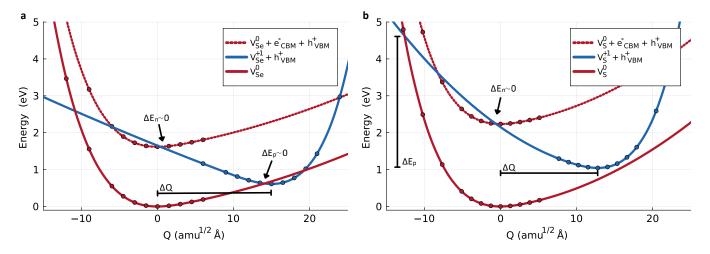


FIG. 6. Configuration coordinate diagrams for BiSeBr and BiSeBr. Configuration coordinate diagrams for a. BiSeBr V_{Se} (0/+1) and b. BiSBr V_{S} (0/+1). The dots represent potential energies computed from first-principles, and the solid lines are their corresponding quadratic spline interpolation and extrapolation. ΔQ represents the generalized distance between charge states and ΔE_x the electron (n)/hole (p) energy carrier capture barriers.

Material	E _g (eV)	Radiative limit			Nonradiative limit					
		η (%)	$V_{\rm oc}~(V)$	FF (%)	Bi-poor			Ch-poor		
					η (%)	$V_{\rm oc}$ (V)	FF (%)	η (%)	$V_{\rm oc}\ (V)$	FF (%)
BiSI	1.96	23.63	1.66	92.08	23.63	1.66	92.08	23.20	1.66	90.66
BiSeI	1.60	30.38	1.33	90.54	30.38	1.33	90.54	24.23	1.08	88.81
BiSBr	2.24	17.65	1.92	92.94	17.65	1.92	92.94	17.26	1.91	91.25
${ m BiSeBr}$	1.62	27.96	1.35	90.66	27.96	1.35	90.66	18.21	0.91	87.23

TABLE II. Estimated power conversion efficiencies and related properties considering different limits and growth conditions. Band gap, power conversion efficiencies (η), open-circuit voltages (V_{oc}) and fill factors (FF) for BiSI, BiSeI, BiSeI and BiSeBr estimated at the radiative and nonradiative limits.

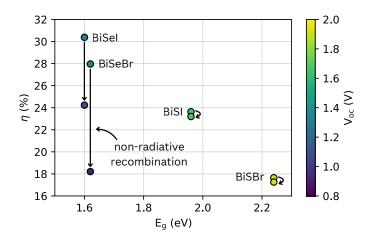


FIG. 7. Impact of non-radiative recombination in the estimated power conversion efficiencies and open-circuit voltage. Power conversion efficiency and open circuit voltage of BiSI, BiSeI, BiSBr, and BiSeBr as a function of bandgap. Colored points indicate the open-circuit voltage for each material with a heatmap scale. Arrows indicate the drop in efficiency from the radiative to the nonradiative limit under chalcogen-poor conditions.

broader family: in BiSI and BiSBr, sulfur-related defects

 $(V_S,\,Bi_S)$ produce negligible recombination losses, keeping their efficiencies effectively identical to the radiative limit. Thus, the dominant factor limiting nonradiative performance in MChX is the presence of chalcogen-site vacancies, whereas antisite defects appear comparatively harmless for device operation.

III. DISCUSSION

The nonradiative efficiency losses in MChX (Table II and Fig. 7) are comparable to those observed in other light absorber materials, such as ${\rm Cu_2ZnSnS_4,}^{45}$ ${\rm Cu_2ZnSnSe_4,}^{40}$ and CdTe. 31 Both BiSeI and BiSeBr exhibit pronounced reductions in PCE relative to their radiative limits of approximately 6% and 10%, respectively. These losses are accompanied by marked decreases in open-circuit voltage (${\rm V_{oc}}=1.08~{\rm V}$ for BiSeI and 0.91 V for BiSeBr) and fill factor (88.81% and 87.23%, respectively), reflecting a deterioration in electronic quality under illumination and a reduced charge-transport efficiency. Interestingly, this loss mechanism arises not from exceptionally strong recombination activity but from the high equilibrium concentration of selenium vacancies (${\rm V_{Se}}$), whose relatively low formation

energies (≈ 0.8 eV) lead to abundant deep-level traps. Hence, performance limitations in MChX absorbers are mainly driven by the prevalence of intrinsic point defects rather than their individual recombination strengths. Effective passivation of these defects is therefore a promising avenue for improving device performance. Our first-principles results demonstrate that adopting Bi-poor synthesis conditions can significantly raise defect formation energies, thereby reducing their population. Under such conditions, the calculated efficiency for BiSeI and BiSeBr are 30.38% and 27.96%, respectively, closely approaching their ideal detailed-balance limits.

A complementary route to mitigate these defectinduced PCE losses may involve targeted ion substitution, which provides a chemically guided approach to engineering defect tolerance. The similar van der Waals radii of Bi ($r_{Bi} = 207 \text{ pm}$), Se ($r_{Se} = 190 \text{ pm}$), and halogens such as Br ($r_{Br} = 185 \text{ pm}$) or I ($r_{I} = 198 \text{ pm}$) enable facile atomic interchange during synthesis, promoting antisite and vacancy formation. To counteract this atomic interchangeability, we propose controlled substitutions involving ions with larger size mismatches to hinder defect diffusion and reduce antisite formation, while maintaining desirable optoelectronic characteristics. This rationale explains the enhanced defect tolerance observed in the sulfides BiSI and BiSBr, where the substantial ionic radius contrast among Bi, S (r_S = 180 pm), and halogens suppresses in part defect formation. These insights suggest that careful compositional tuning, particularly through I-on-Br substitution, offers a promising strategy to reduce formation of defect in MChX semiconductors and boost their efficiency.

The findings presented in this study are significant for the field of photovoltaics, as they provide a pathway to enhance the efficiency of MChX light absorbers, a promising class of nontoxic and thermodynamically stable materials. By addressing defect chemistry and proposing effective passivation strategies, this study not only bridges the gap between theoretical predictions and experimental performance but also establishes a framework for designing more efficient solar absorbers with improved defect tolerance. These insights could pave the way for next-generation photovoltaic technologies with higher efficiencies and broader applicability.

Based on our theoretical findings, we suggest two promising experimental MChX research directions: (i) exploring ion substitution strategies (either full replacement or partial extrinsic doping) to suppress defect formation and weaken electron—phonon interactions that drive nonradiative recombination, and (ii) pursuing synthesis under chalcogen-rich conditions, which would intrinsically minimize the concentration of detrimental vacancies and thereby reduce defect-mediated efficiency losses.

IV. CONCLUSIONS

This work identifies intrinsic point defects as a key bottleneck limiting the photovoltaic performance of pnictogen chalcohalides. Through a systematic first-principles computational study involving BiSI, BiSeI, BiSBr, and BiSeBr, we show that chalcogen vacancies dominate non-radiative recombination, with selenium vacancies being particularly harmful due to their deep electronic transition states and strong electron–phonon coupling. In contrast, sulfur vacancies couple more weakly and are comparatively benign, highlighting the decisive influence of local chemical environment on defect tolerance.

Our defect-limited efficiency analysis shows that while sulfides retain efficiencies close to their radiative limits, the selenides suffer losses of up to 10% on efficiency, accompanied by severe reductions in open-circuit voltage. Crucially, we also demonstrate that synthesis conditions and targeted anion substitutions can mitigate the impact of harmful vacancies: Bi-poor growth suppresses $V_{\rm Se}$ formation, while S-for-Se or I-for-Br substitutions improve defect tolerance without sacrificing favorable optoelectronic properties. These findings establish a general design principles for defect passivation in emergent optoelectronic materials, paving the way toward more efficient and defect-tolerant photovoltaic technologies.

METHODS

A. First-Principles Calculations

Ab initio calculations based on density functional theory (DFT) were performed to analyse point defects in MChX. These calculations were conducted with the VASP software package⁴⁶ using the generalized gradient approximation to the exchange-correlation energy due to Perdew et al. (PBE).⁴⁷ Since MChX are van der Waals materials, long-range dispersion interactions were taken into account through the D3 scheme. 48 Spin-orbit coupling effects, which are particularly relevant for Bi-based MChX^{4,19,32} (see details in Supplementary Discussion), were taken into account along with range-separated hybrid functionals containing an exact Hartree-Fock exchange fraction of 25% (i.e., HSE+SOC⁴⁹⁻⁵¹). All defective atomic structures were fully optimized at the HSE+D3+SOC level, a methodology shown to accurately reproduce experimental results for MChX and other similar materials.^{3,19,52} The projector augmentedwave method was used to represent the ionic $cores^{53}$ and for each element the maximum possible number of valence electronic states was considered. Wave functions were represented in a plane-wave basis typically truncated at 300 eV. By using these parameters and a dense Γ-centered k-point grid for reciprocal space Brillouin zone integration of $2 \times 1 \times 2$, the resulting energies were converged to within 1 meV per formula unit. In the geometry relaxations, a tolerance of $0.5 \text{ meV} \cdot \text{Å}^{-1}$ was imposed in the atomic forces. Defect calculations were performed in $3\times2\times1$ ($12.6\times17.2\times10.3$ Å for BiSI, $12.8\times18.1\times11.3$ Å for BiSeI, $12.1\times16.1\times9.5$ Å for BiSBr and $12.2\times16.3\times10.1$ Å for BiSeBr) supercells.

B. Exploration of the Potential Energy Surface

Conventional approaches to generating defect configurations³³ from pristine cells fail to find many lowering-energy conformations, which might have a crucial effect in the conclusions. Therefore, once a defect is generated (e.g., extracting a bismuth atom), we look for distortions of the initial lattice configuration to locally explore the potential energy surface. These distortions were generated with the ShakeNBreak software package. ^{26,54}

Initially, all the trial defect configurations were relaxed using Γ -point reciprocal space sampling and the HSE+D3 functional. Only the minimum-energy configurations were kept. Next, the ionic relaxations were repeated considering a larger **k**-point grid of $2\times 1\times 2$ (Γ -centered). After that, the relaxations were repeated considering SOC corrections. Finally, single-point energy calculations were performed using the previously-converged electronic wavefunctions and equilibrium structures. Nonspherical contributions to the gradient of the density within the PAW spheres were taken into account to improve numerical accuracy.

C. Point-Defect Formation Energies

Point defects include vacancies, where an atom is removed from the lattice (e.g., V_{Bi}), antisites, where an atom is replaced by another of a different species (e.g., I_S), and interstitials, where an atom occupies a nonequilibrium lattice site (e.g., Br_i). Computational approaches for studying these are well-established, relying on accurate first-principles energy calculations combined with exhaustive exploration of the defect local environment. 54-56 For this work, we employed the supercell approach, which involves modeling point defects within sufficiently large supercells to minimize spurious interactions. We systematically analyzed all possible vacancy and antisite defects, considering both neutral and charged states. The doped simulation package⁵⁷ was used to generate defect structures and calculation inputs, determine chemical potential limits, and analyze the defects simulation results. The ShakeNBreak^{54,58} defect structure-search approach was employed, revealing numerous significant energy-lowering reconstructions, consistent with observations in similar low-dimensional chalcogenide systems.^{20,39,59}

The formation energy of a point defect with charge q,

 D^q , can be expressed as:⁵⁵

$$E_{\rm f}(D^q) = E_T(D^q) - E_T({\rm pristine}) + + qE_F + \sum_i n_i \mu_i + E_{corr}(D^q) , \qquad (1)$$

where $E_T(D^q)$ and $E_T(\text{pristine})$ are the static energies of defected and pristine supercells (energy per formula unit), respectively, μ_i corresponds to chemical potential of species i (this is, the energy required to extract one single atom), n_i the number of extracted atoms (positive or negative if extracted or added to the pristine cell, respectively), E_F the Fermi energy (energy needed to extract an electron), and E_{corr} the finite-size corrections based on spurious interactions between charged defects due to the periodic boundary conditions.

Here we considered two different contributions to the finite-size energy correction: point-charge (due to the spurious electrostatic interactions of a defect with its images) and band-alignment corrections (charged defects spuriously change the electrostatic potential of the system). Both corrections are computed together from an extension of the Freysoldt-Neugebauer-Van de Walle⁵⁵ correction scheme to anisotropic materials,⁵⁶ as implemented in the doped defect simulation package.⁵⁷

D. Defect-Limited Efficiency

The strength of nonradiative recombination was quantified through the electron and hole capture coefficients corresponding to each charge state of the defect, as obtained with the CarrierCapture.jl package. 23,60

In this theoretical framework, the maximum photovoltaic efficiency limited by defects⁴⁴ for an absorber of thickness W, under an incident photon flux Φ at a photon energy E and bias voltage V, is expressed as:

$$\eta = \max_{V} \left(\frac{JV}{q \int_{0}^{\infty} E\Phi(E) dE} \right) , \qquad (2)$$

where q denotes the elementary charge and J the maximum defect-limited current density, defined by:

$$J(W,V) = J_{SC}(W) + J_0^{rad}(W,V) + J_0^{nonrad}(W,V)$$
, (3)

Here, J_{SC} represents the short-circuit current, while J_0^{rad} corresponds to the radiative saturation current. These two contributions describe recombination through photon emission, whereas J_0^{nonrad} accounts for nonradiative processes:

$$J_{SC}(W) = q \int_0^\infty a(E, W) \Phi(E) dE \tag{4}$$

$$J_0^{rad}(W,V) = q \frac{2\pi}{c^2 h^3} \left(1 - e^{\frac{qV}{k_B T}} \right) \times$$

$$\times \int_0^\infty a(E,W) \left(e^{\frac{E}{k_B T}} - 1 \right)^{-1} E^2 dE$$

$$(5)$$

$$J_0^{nonrad}(W, V) = -qWR^{SRH}(V) , \qquad (6)$$

with a the absorptivity (assuming unit quantum efficiency such that each absorbed photon produces an electron–hole pair). The Shockley–Read–Hall recombination rate is approximated as:

$$R_{SRH} \approx \sum \Delta n/p \ N_T C_{n/p} \ ,$$
 (7)

where Δn and Δp are the excess carrier concentrations, N_T the defect concentration, and the summation runs over all recombination-active centers. The capture coefficient, 23,40 $C_{n/p}$, depends on the electron-phonon interaction strength (W_{ct}) and the overlap of vibrational wave functions $(\langle \zeta_{cm} | \Delta Q | \zeta_{tn} \rangle)$:

$$C_{n/p} = \Omega \frac{2\pi}{\hbar} |W_{ct}|^2 \sum_{m,n} w_m \langle \zeta_{cm} | \Delta Q | \zeta_{tn} \rangle^2 \times \delta(\Delta E_{n/p} + \epsilon_{cm} - \epsilon_{tn}) ,$$
(8)

where Ω is the supercell volume, g the defect degeneracy, ζ the phonon wave function, and ΔQ the effective configuration coordinate, with c and t labeling free-carrier and trap states, respectively. The temperature dependence arises from the thermal occupation probability w_m of the initial vibrational mode. To incorporate the role of capture dynamics on photovoltaic efficiency, calculations were carried out with the TLC code. ⁴⁰

DATA AVAILABILITY

The data that support the findings of this study have been made publicly available, ⁶¹ comprising the single-point energy and local potential calculations for all relaxed defects, along with all input files needed for reproducibility using the doped Python package. ⁵⁷

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AUTHOR CONTRIBUTIONS

C.L., E.S. and C.C. conceived the study and planned the research, which was discussed in-depth with the rest of the co-authors. C.L. and S.K. performed the first-principles calculations and analyzed the results. The manuscript was written by C.L. and C.C., with substantial input from the rest of the co-authors.

ADDITIONAL INFORMATION

Supplementary information is available in the online version of the paper.

COMPETING FINANCIAL INTERESTS

The authors declare no competing financial interests.

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